

K4143-VB Datasheet N-Channel 60 V (D-S) MOSFET

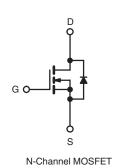
PRODUCT SUMMARY						
V _{DS} (V)	60					
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.027				
Q _g (Max.) (nC)	95					
Q _{gs} (nC)	27					
Q _{gd} (nC)	46					
Configuration	Single					

FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- · Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available

GDS

TO-220 FULLPAK



ABSOLUTE MAXIMUM RATINGS $T_C = 25 \degree C$, unless otherwise noted								
PARAMETER			SYMBOL	LIMIT	UNIT			
Drain-Source Voltage		V _{DS}	60	- V				
Gate-Source Voltage			V _{GS}			± 20		
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	I _D	45				
		$T_C = 100 ^{\circ}C$		30	А			
Pulsed Drain Current ^a			I _{DM}	220				
Linear Derating Factor			0.32	W/°C				
Single Pulse Avalanche Energy ^b		E _{AS}	100	mJ				
Maximum Power Dissipation	T _C = 25 °C		PD	52	W			
Peak Diode Recovery dV/dtc		dV/dt	4.5	V/ns				
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C				
Soldering Recommendations (Peak Temperature)	for ⁻	10 s		300 ^d	C			
Mounting Torque	raue 6-32 or M3 screw 10 lbf ·	lbf ⋅ in						
	0-02 OF MO SCIEW			1.1	N · m			

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 129 µH, $R_G = 25 \Omega$, $I_{AS} = 30 \text{ A}$ (see fig. 12). c. $I_{SD} \le 52 \text{ A}$, $dI/dt \le 250 \text{ A/µs}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

d. 1.6 mm from case.

THERMAL RESISTANCE RAT	TINGS							
PARAMETER	SYMBOL	ТҮР	•	MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-		65			°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-		3.1			C/W	
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,					•			1
PARAMETER	SYMBOL	TES	T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT
Static								•
Drain-Source Breakdown Voltage	V _{DS}	V_{GS} = 0 V, I _D = 250 µA			60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	I _D = 1 mA	-	0.060	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 2	250 μΑ	1.0	-	3.0	V
Gate-Source Leakage	I _{GSS}	,	$V_{\rm GS} = \pm 20$	V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-	-	25	μA
		$V_{DS} = 48 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 150 ^{\circ}\text{C}$			-	-	250	
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	I _D	= 18 A ^b	-	0.027	-	Ω
Forward Transconductance	g _{fs}	V _{DS} =	= 25 V, I _D =	18 A ^b	15	-	-	S
Dynamic								
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,		-	1500	-	
Output Capacitance	C _{oss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5		-	720	-	рF	
Reverse Transfer Capacitance	C _{rss}			-	100	-		
Drain to Sink Capacitance	С			-	12	-		
Total Gate Charge	Qg				-	-	95	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		A, V _{DS} = 48 V, iig. 6 and 13 ^b	-	-	27	nC
Gate-Drain Charge	Q _{gd}	see ng			-	-	46	
Turn-On Delay Time	t _{d(on)}				-	19	-	
Rise Time	t _r	$\label{eq:V_DD} \begin{array}{l} {\sf V}_{\rm DD} = 30 \ {\sf V}, \ {\sf I}_{\rm D} = 52 \ {\sf A}, \\ {\sf R}_{\rm G} = 9.1 \ \Omega, \ {\sf R}_{\rm D} = 0.54 \ \Omega, \\ {\sf see \ fig. \ 10^b} \end{array}$		-	120	-	ns	
Turn-Off Delay Time	t _{d(off)}			-	55	-		
Fall Time	t _f			-	86	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from		-	4.5	-	nH	
Internal Source Inductance	Ls	package and center of die contact			-	7.5		-
Drain-Source Body Diode Characteristic	s	•				-		
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	45	A	
Pulsed Diode Forward Currenta	I _{SM}			-	-	120		
Body Diode Voltage	V_{SD}	$T_{\rm J}$ = 25 °C, I _S = 30 A, V _{GS} = 0 V ^b		-	-	2.5	V	
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 52 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	140	300	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.2	2.8	μC	
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time i	s negligible (turn	-on is dor	ninated b	y L _S and I	L _D)

Notes

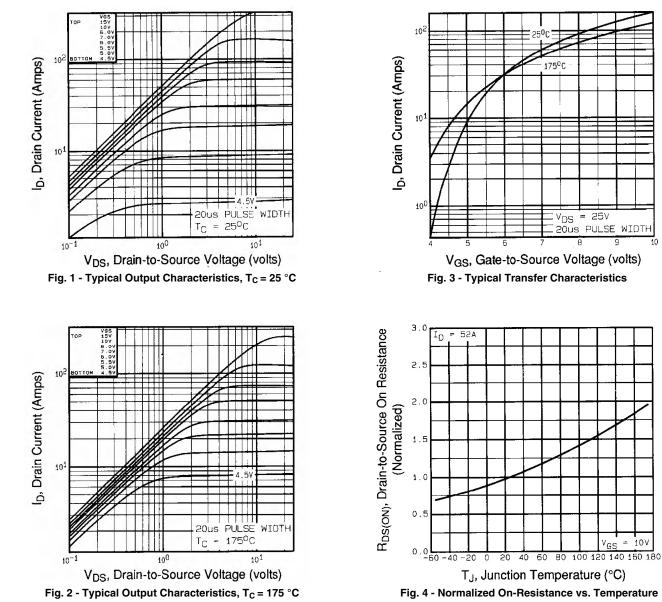
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



- 25v

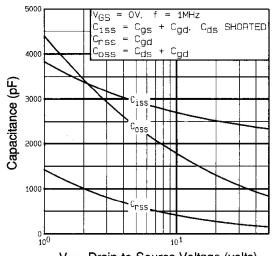
V_{GS} = 10V

10



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





V_{DS}, Drain-to-Source Voltage (volts) Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

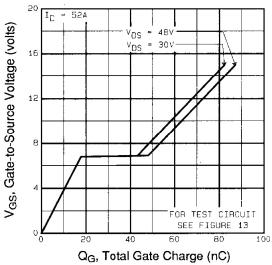


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

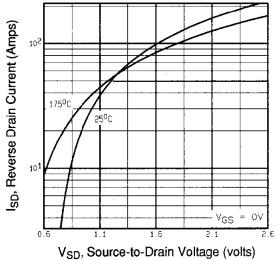
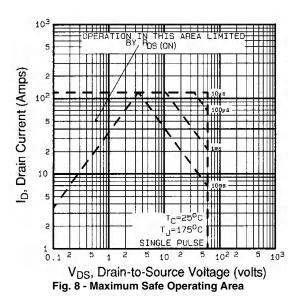


Fig. 7 - Typical Source-Drain Diode Forward Voltage



K4143-VB



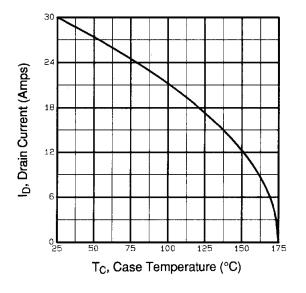


Fig. 9 - Maximum Drain Current vs. Case Temperature

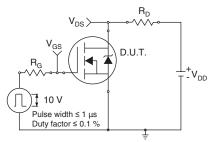


Fig. 10a - Switching Time Test Circuit

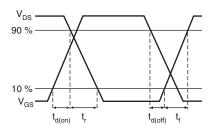


Fig. 10b - Switching Time Waveforms

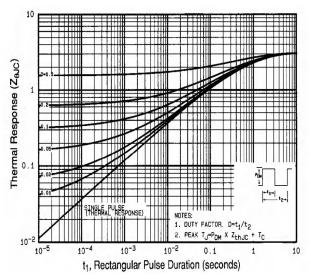
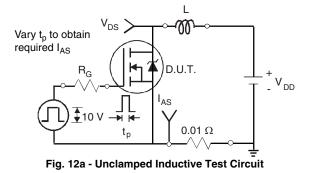


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



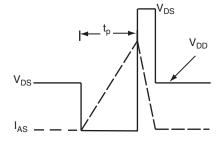
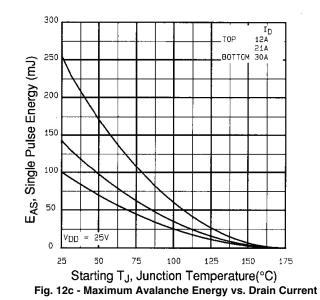


Fig. 12b - Unclamped Inductive Waveforms





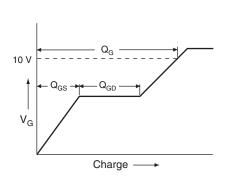


Fig. 13a - Basic Gate Charge Waveform

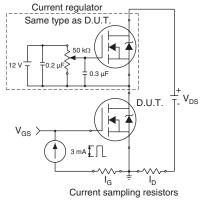
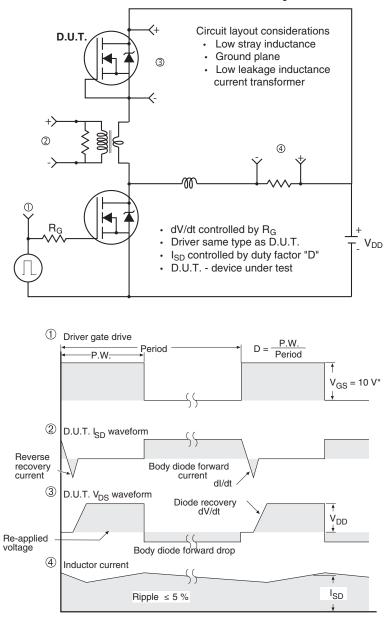


Fig. 13b - Gate Charge Test Circuit





Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel



Disclaimer

All products due to improve reliability, function or design or for other reasons, product specifications and data are subject to change without notice.

Taiwan VBsemi Electronics Co., Ltd., branches, agents, employees, and all persons acting on its or their representatives (collectively, the "Taiwan VBsemi"), assumes no responsibility for any errors, inaccuracies or incomplete data contained in the table or any other any disclosure of any information related to the product.(www.VBsemi.com)

Taiwan VBsemi makes no guarantee, representation or warranty on the product for any particular purpose of any goods or continuous production. To the maximum extent permitted by applicable law on Taiwan VBsemi relinquished: (1) any application and all liability arising out of or use of any products; (2) any and all liability, including but not limited to special, consequential damages or incidental; (3) any and all implied warranties, including a particular purpose, non-infringement and merchantability guarantee.

Statement on certain types of applications are based on knowledge of the product is often used in a typical application of the general product VBsemi Taiwan demand that the Taiwan VBsemi of. Statement on whether the product is suitable for a particular application is non-binding. It is the customer's responsibility to verify specific product features in the products described in the specification is appropriate for use in a particular application. Parameter data sheets and technical specifications can be provided may vary depending on the application and performance over time. All operating parameters, including typical parameters must be made by customer's technical experts validated for each customer application. Product specifications do not expand or modify Taiwan VBsemi purchasing terms and conditions, including but not limited to warranty herein.

Unless expressly stated in writing, Taiwan VBsemi products are not intended for use in medical, life saving, or life sustaining applications or any other application. Wherein VBsemi product failure could lead to personal injury or death, use or sale of products used in Taiwan VBsemi such applications using client did not express their own risk. Contact your authorized Taiwan VBsemi people who are related to product design applications and other terms and conditions in writing.

The information provided in this document and the company's products without a license, express or implied, by estoppel or otherwise, to any intellectual property rights granted to the VBsemi act or document. Product names and trademarks referred to herein are trademarks of their respective representatives will be all.

Material Category Policy

Taiwan VBsemi Electronics Co., Ltd., hereby certify that all of the products are determined to be oHS compliant and meets the definition of restrictions under Directive of the European Parliament 2011/65 / EU, 2011 Nian. 6. 8 Ri Yue restrict the use of certain hazardous substances in electrical and electronic equipment (EEE) - modification, unless otherwise specified as inconsistent.(www.VBsemi.com)

Please note that some documents may still refer to Taiwan VBsemi RoHS Directive 2002/95 / EC. We confirm that all products identified as consistent with the Directive 2002/95 / EC European Directive 2011/65 /.

Taiwan VBsemi Electronics Co., Ltd. hereby certify that all of its products comply identified as halogen-free halogen-free standards required by the JEDEC JS709A. Please note that some Taiwanese VBsemi documents still refer to the definition of IEC 61249-2-21, and we are sure that all products conform to confirm compliance with IEC 61249-2-21 standard level JS709A.